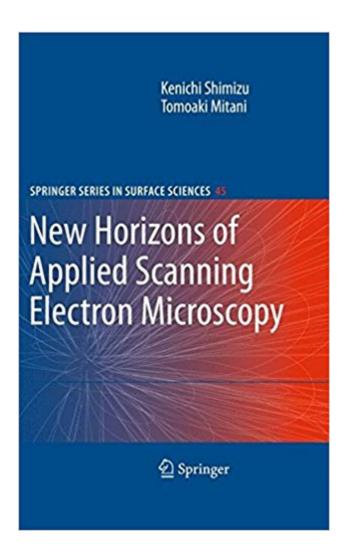


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New Horizons Of Applied Scanning Electron Microscopy (Springer Series In Surface Sciences)





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In modern scanning electron microscopy, sample surface preparation is of key importance, just as it is in transmission electron microscopy. With the procedures for sample surface preparation provided in the present book, the enormous potential of advanced scanning electron microscopes can be realized fully. This will take the reader to an entirely new level of scanning electron microscopy and finely-detailed images never seen before.

Book Information

Series: Springer Series in Surface Sciences (Book 45)

Hardcover: 182 pages

Publisher: Springer; 2010 edition (December 2, 2009)

Language: English

ISBN-10: 3642031595

ISBN-13: 978-3642031595

Product Dimensions: 6.3 x 0.6 x 9.2 inches

Shipping Weight: 1.2 pounds (View shipping rates and policies)

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